



85V N-Channel Trench MOSFET

General Description	Product Summary
<ul style="list-style-type: none">• Trench Power technology• Low $R_{DS(ON)}$• Low Gate Charge• Optimized for fast-switching applications	V_{DS} 85V I_D (at $V_{GS}=10V$) 115A $R_{DS(ON)}$ (at $V_{GS}=10V$) < 8.5mΩ
Applications <ul style="list-style-type: none">• Synchronous Rectification in DC/DC and AC/DC Converters• Isolated DC/DC Converters in Telecom and Industrial	100% UIS Tested



Part Number	Package Type	Form	Marking
TTD115N08A	TO-252	Tape & Reel	115N08A

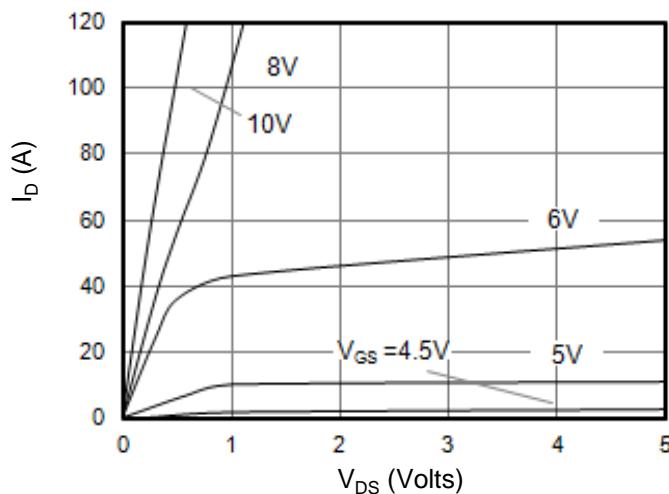
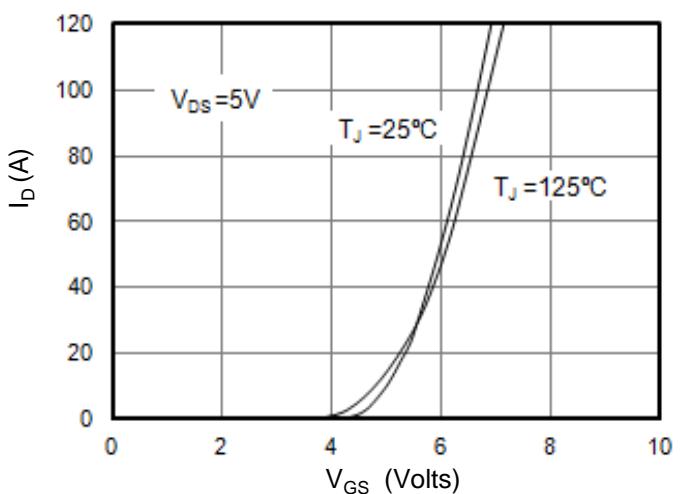
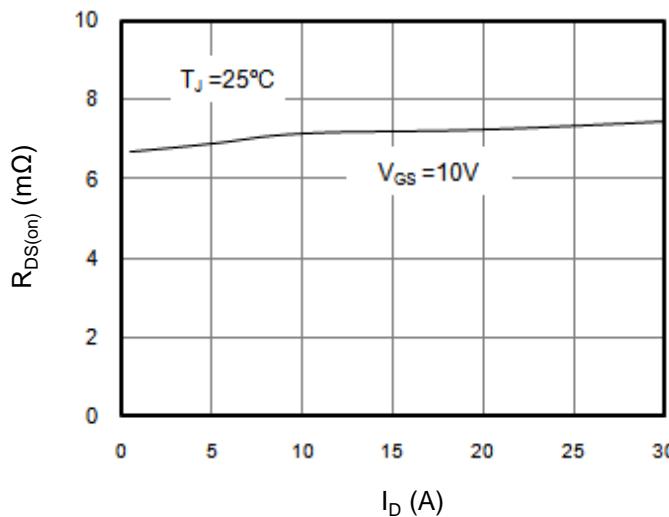
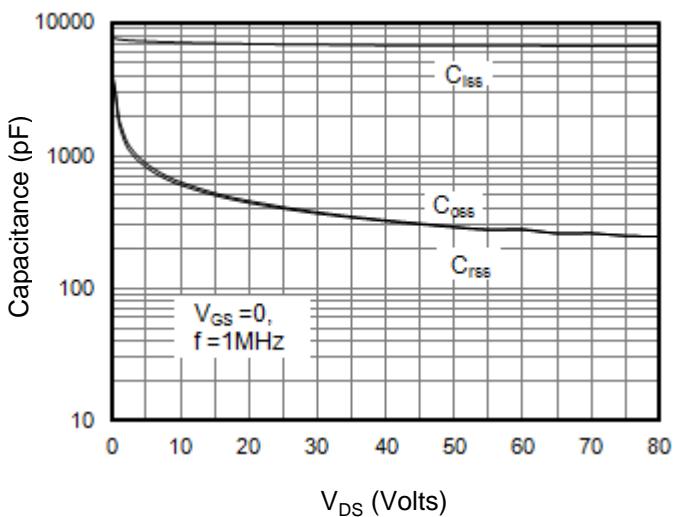
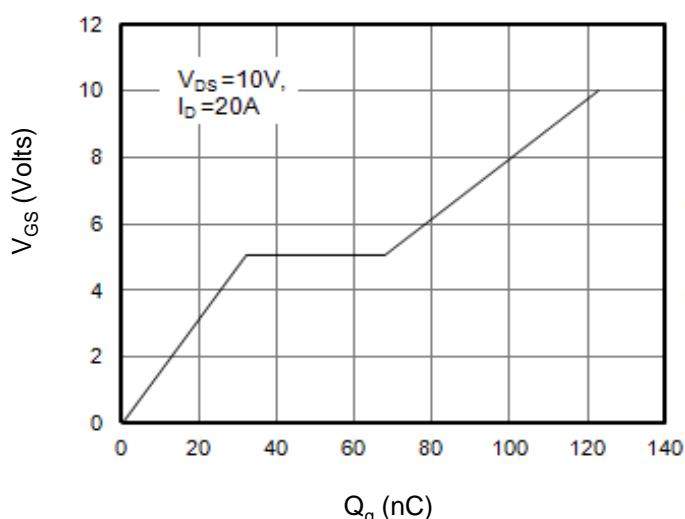
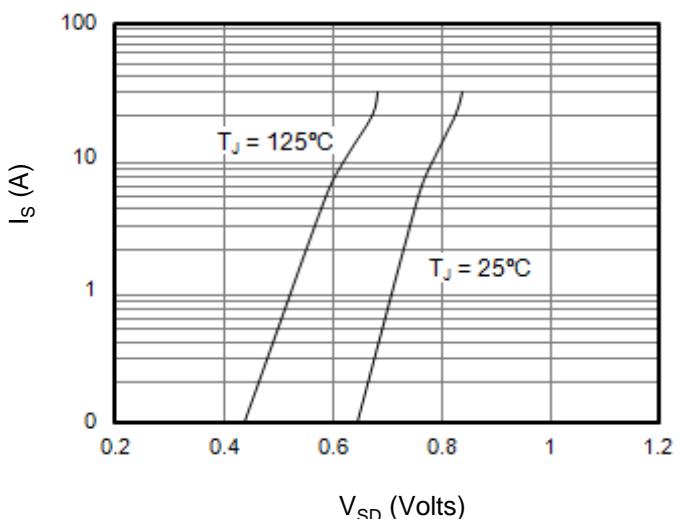
Absolute Maximum Ratings ($T_A = 25^\circ C$ unless otherwise noted)			
Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	85	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ^B	I_D	46	A
		46	
Pulsed Drain Current ^A	I_{DM}	460	A
Avalanche Current ^A	I_{AS}	45	A
Single Pulse Avalanche Energy ^A $L = 0.3mH$	E_{AS}	303	mJ
Power Dissipation ^C	P_D	245	W
		123	W
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 175	°C

Thermal Characteristics			
Parameter	Symbol	Maximum	Units
Maximum Junction-to-Case	R_{eJC}	0.61	°C/W
Maximum Junction-to-Ambient	R_{eJA}	100	

**Electrical Characteristics($T_J = 25^\circ\text{C}$ unless otherwise noted)**

Symbol	Parameter	Conditions	Value			Units
			Min	Typ	Max	
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	85	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 85\text{V}, V_{GS} = 0\text{V}$	$T_J = 25^\circ\text{C}$	--	--	1
			$T_J = 125^\circ\text{C}$	--	--	100
I_{GSS}	Gate-Body Leakage Current	$V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$	--	--	± 100	nA
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	2	3	4	V
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS} = 10\text{V}, I_D = 30\text{A}$	--	7.3	8.5	$\text{m}\Omega$
g_{FS}	Forward Transconductance	$V_{DS} = 5\text{V}, I_D = 20\text{A}$	--	38	--	S
V_{SD}	Diode Forward Voltage	$I_S = 30\text{A}, V_{GS} = 0\text{V}$	--	--	1	V
I_S	Maximum Body-Diode Continuous Current ^B	--	--	--	46	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{GS} = 0\text{V}, V_{DS} = 40\text{V}, f = 1\text{MHz}$	--	6710	--	pF
C_{oss}	Output Capacitance		--	328	--	
C_{rss}	Reverse Transfer Capacitance		--	320	--	
R_g	Gate Resistance	$f = 1\text{MHz}$	--	1.46	--	Ω
SWITCHING PARAMETERS						
Q_g	Total Gate Charge	$V_{GS} = 10\text{V}, V_{DS} = 40\text{V}, I_D = 20\text{A}$	--	123	--	nC
Q_{gs}	Gate Source Charge		--	32	--	
Q_{gd}	Gate Drain Charge		--	36	--	
$t_{D(\text{on})}$	Turn-On Delay Time	$V_{GS} = 10\text{V}, V_{DS} = 40\text{V}, I_D = 20\text{A}, R_G = 2.5\Omega$	--	24	--	ns
t_r	Turn-On Rise Time		--	19	--	
$T_{D(\text{off})}$	Turn-Off Delay Time		--	70	--	
t_f	Turn-Off Fall Time		--	30	--	
t_{rr}	Body Diode Reverse Recovery Time	$I_F = 20\text{A}, di/dt = 100\text{A}/\mu\text{s}$	--	37	--	ns
Q_{rr}	Body Diode Reverse Recovery Charge		--	58	--	nC

- A. Single pulse width limited by maximum junction temperature.
- B. The maximum current rating is package limited.
- C. The power dissipation P_D is based on $T_{J(\text{MAX})} = 175^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 1: On-Region Characteristics

Figure 2: Transfer Characteristics

Figure 3: On-Resistance vs. Drain Current

Figure 4: Capacitance Characteristics

Figure 5: Gate Charge Characteristics

Figure 6: Body Diode Forward Voltage

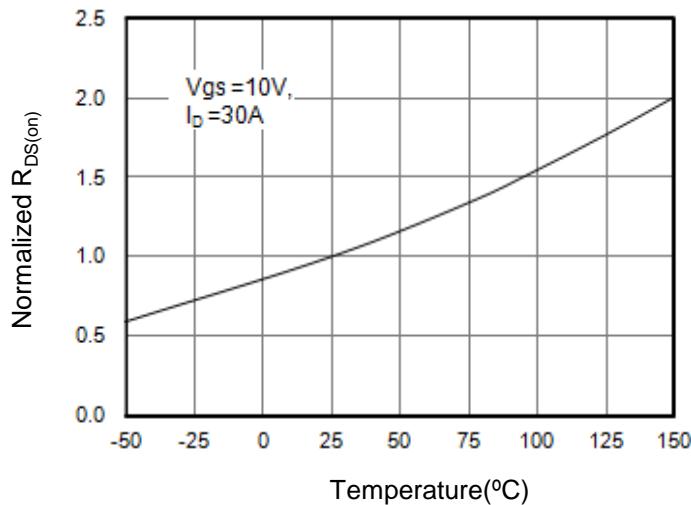
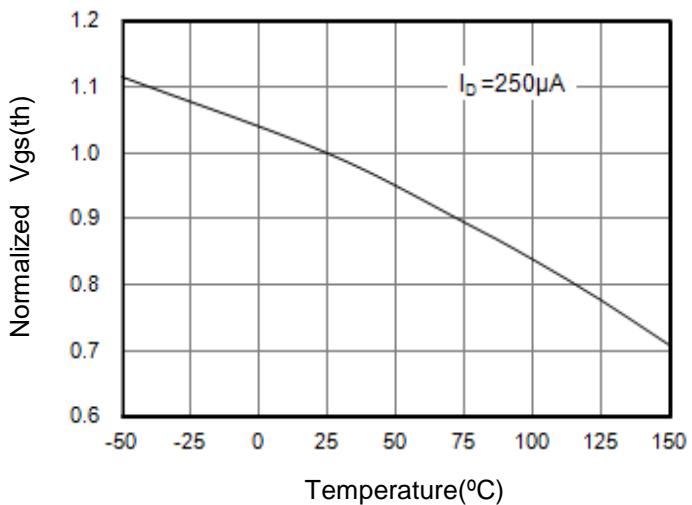
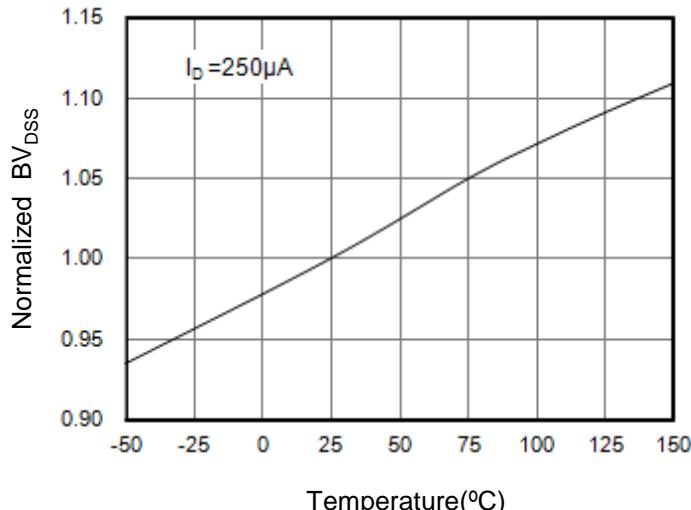
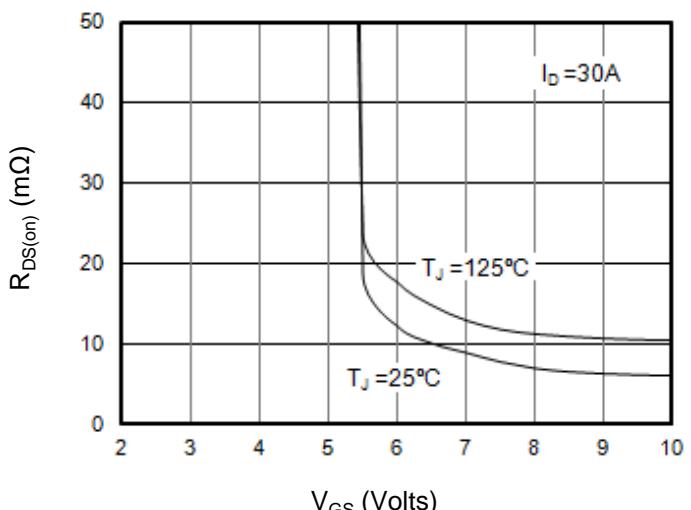
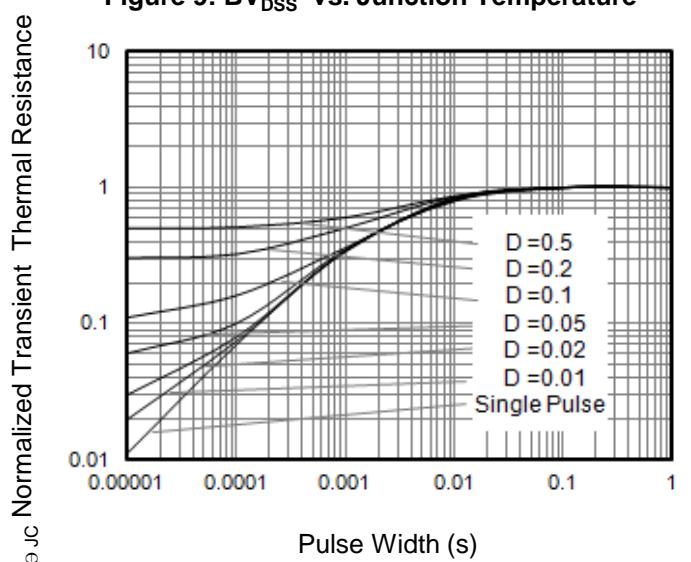
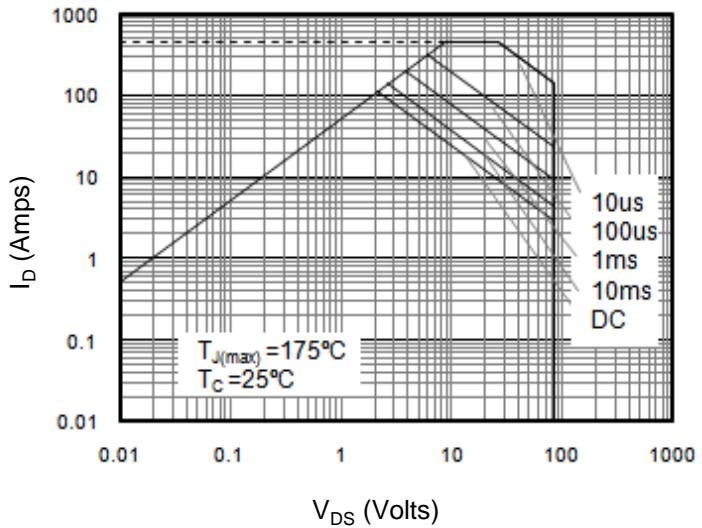
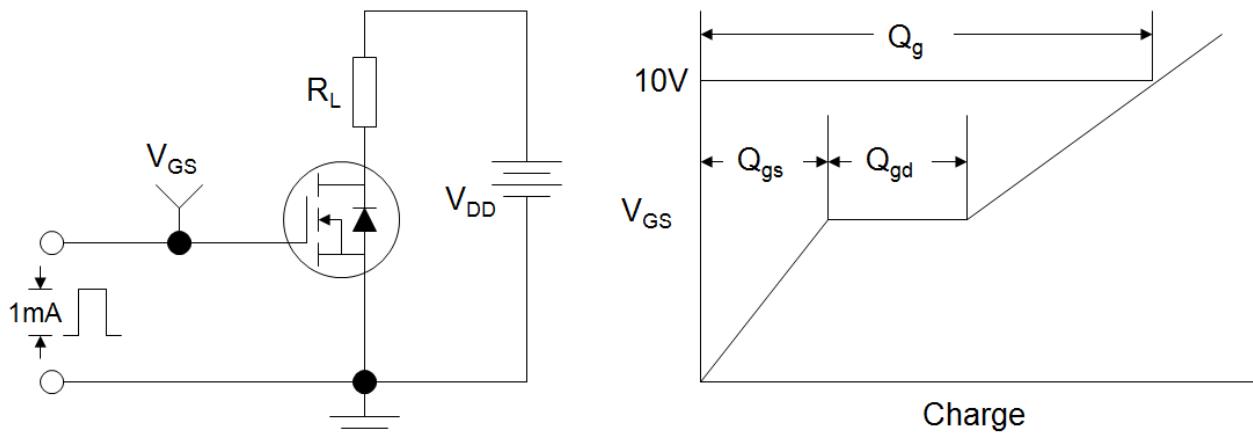
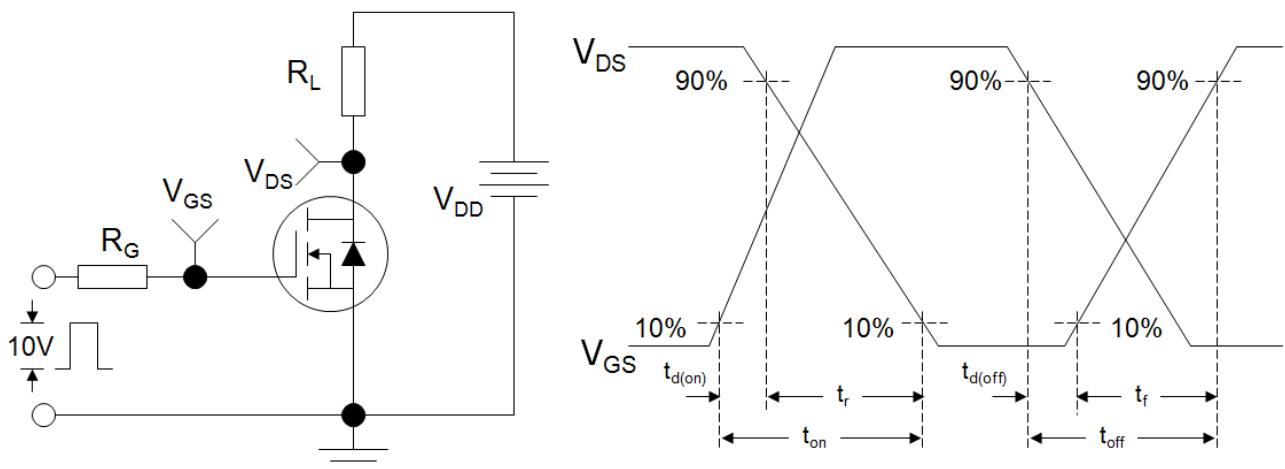
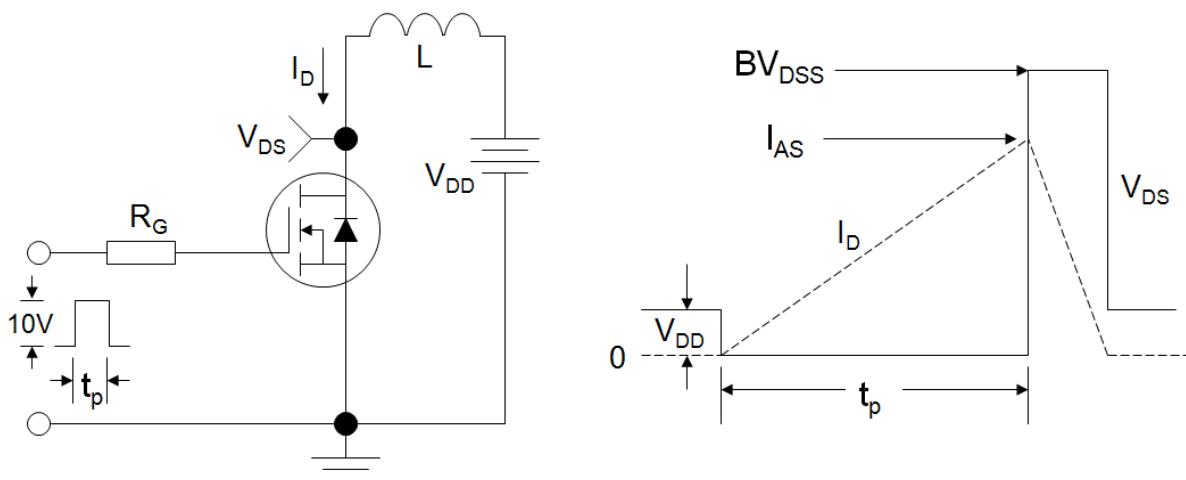
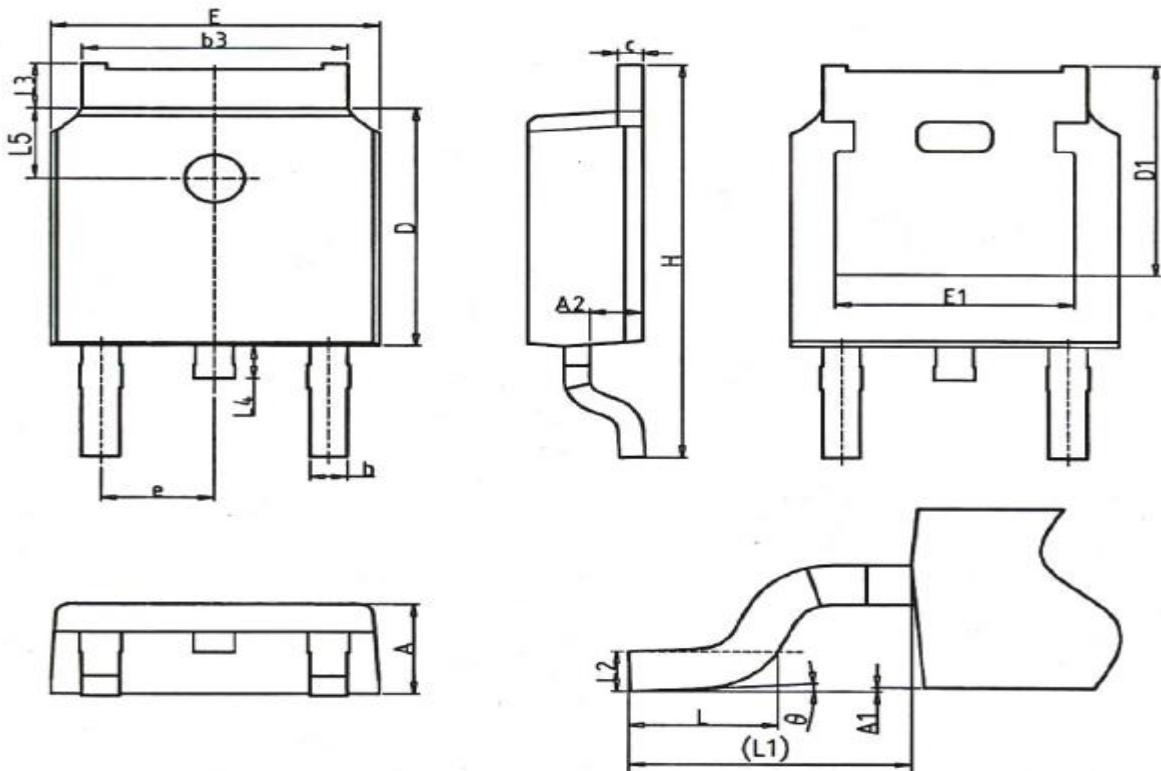
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 7: On-Resistance vs. Junction Temperature

Figure 8: Vgs(th) vs. Junction Temperature

Figure 9: BV_{DSS} vs. Junction Temperature

Figure 10: On-Resistance vs. Gate-Source Voltage

Figure 11: Normalized Transient Thermal Resistance

Figure 12: Safe Operating Area

Figure A: Gate Charge Test Circuit and Waveforms

Figure B: Resistive Switching Test Circuit and Waveforms

Figure C: Unclamped Inductive Switching (UIS) Test Circuit and Waveforms


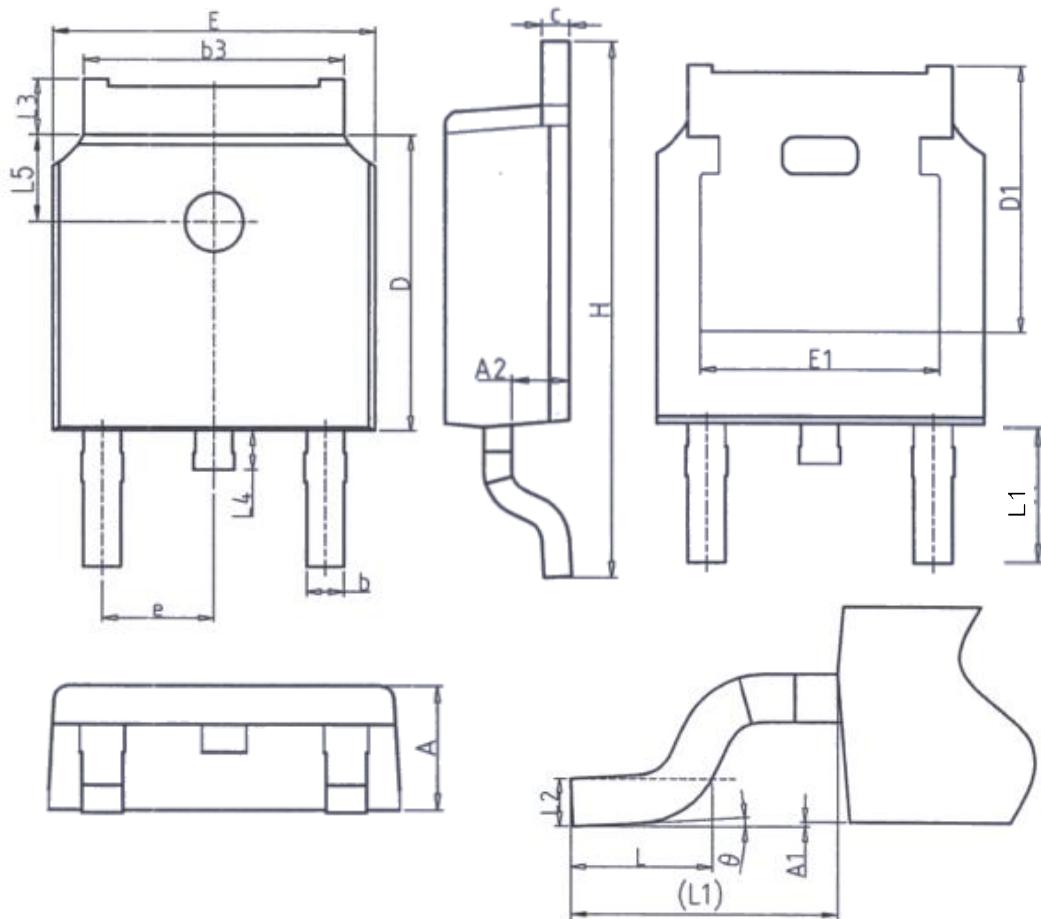


TO-252(海天)



SYMBOL	mm		
	MIN	NOM	MAX
A	2.20	2.30	2.38
A1	0.00	-	0.20
A2	0.97	1.07	1.17
b	0.68	0.78	0.90
b3	5.20	5.33	5.46
c	0.43	0.53	0.61
D	5.98	6.10	6.22
D1	5.30REF		
E	6.40	6.60	6.73
E1	4.63	-	-
e	2.286BSC		
H	9.40	10.10	10.50
L	1.38	1.50	1.75
L1	2.90REF		
L2	0.51BSC		
L3	0.88	-	1.28
L4	0.50	-	1.00
L5	1.65	1.80	1.95
θ	0°	-	8°

TO-252(华羿)



Unit: mm			
Symbol	Min	Nom	Max
A	2.20	2.30	2.38
A1	0.00	-	0.10
A2	0.90	1.01	1.10
b	0.72	-	0.85
b3	5.13	5.33	5.46
c	0.47	-	0.60
D	6.00	6.10	6.20
D1	5.25 REF		
E	6.50	6.60	6.70
E1	4.70	-	-

Unit: mm			
Symbol	Min	Nom	Max
e	2.286BSC		
H	9.80	10.10	10.40
L	1.40	1.50	1.70
L1	2.90REF		
L2	0.508BSC		
L3	0.90	-	1.25
L4	0.60	0.80	1.00
L5	1.8 REF		
Θ	0°	-	8°



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